	DEC ,	<u>\$</u> /		·	<del></del>	<del>                                     </del>			
Form PTO 14199	h	DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.	SERIAL NO.				
Form PTO 14490 DEPARTMENT OF COMMERCE (Modified)				250847US2X	10/810,713				
				APPLICANT					
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Sotoshi YAMADA, et al.					
				FILING DATE	GROUP				
				March 29, 2004	2862				
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	CLASS SUB FILING DATE IF APPROPRIATE			
	AA								
	AB								
	AC								
	AD					<del>   </del>			
ļ	AE	-			<del></del>	<b></b>		·	
					<del> </del>	<del>                                     </del>			
	AF		<b></b>		<del>                                     </del>	<del> </del>		•	
	AG		<del> </del>		<del> </del>	-			
	AH								
	Al		ļ		-		_		
	AJ	·				}			
	AK					ļ			
	AL								
	AM					_			
	AN		<u> </u>		L	<u> </u>		···	
			FC	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
5.4	AQ	2000-80535	03/21/2000	JAPAN (with English Abstract)		1 = 3	<u> </u>	NO X	
gra _	AP	2000-00333	00/21/2000	on the (war English resource)					
	AQ								
	AR	·				<u> </u>		· · · - · · · · · · · · · · · · · ·	
<u></u>			<u></u>						
	AS		<del> </del>			-		·	
	AT				<del></del>	<del> </del>			
	AU					ļ			
ļ	AV	<u></u>		<u> </u>		L			
				(Including Author, Title, Date, Pertinen	•	•			
gal	Kazunori NAKAMURA, et al., "ECT Multi-Sensor for Inspection of Printed Circuit Boards", The 15 <sup>th</sup> Symposium on Electromagnetic and Dynamics, May 28, 2003, pages 339-342 (with English Abstract)								
And	AX	Yasuhiro KATAOKA, et al., "Detection of Eddy Current Change by Slit using GMR Line Sensor", The Papers of Technical Meeting on Magnetics, IEEE Japan (MAG), MAG-02, no. 131-136, October 23, 2002, pages 11-16 (with English Abstract)							
	AY								
	AZ		Additional References sheet(s) attack						
Examiner Jaynhater					Date Considered 3/28/96				
	*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								